

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/086,446 | Applicant(s)/Patent Under Reexamination SEKIGUCHI ET AL. | |
| | Examiner Vu Le | Art Unit 2613 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-4,816,906 | 03-1989 | Kummerfeldt et al. | 348/402.1 |
| | B | US-5,963,259 A | 10-1999 | Nakaya et al. | 375/240.17 |
| | C | US-6,404,815 B1 | 06-2002 | Sekiguchi et al. | 375/240.16 |
| | D | US-5,214,504 A | 05-1993 | Toriu et al. | 375/240.02 |
| | E | US-5,768,438 | 06-1998 | Etoh, Minoru | 382/251 |
| | F | US-5,416,522 A | 05-1995 | Igarashi, Katsuji | 375/240.15 |
| | G | US-5,467,135 A | 11-1995 | Yamane et al. | 375/240.16 |
| | H | US-6,236,682 B1 | 05-2001 | Ota et al. | 375/240.16 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.